## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | YANG ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,777,986	08-2004	Hidaka et al.	327/108
*	В	US-6,603,345	08-2003	Takahashi, Hiroyuki	327/534
*	С	US-6,600,360	07-2003	Mizuno et al.	327/534
*	D	US-6,483,374	11-2002	Mizuno et al.	327/534
*	Ε	US-6,445,222	09-2002	Hidaka et al.	327/108
*	F	US-6,417,722	07-2002	Schneider et al.	327/534
*	G	US-6,323,724	11-2001	Uekubo, Masaki	327/538
*	Н	US-6,246,280	06-2001	Morishita, Fukashi	327/535
*	ı	US-6,107,869	08-2000	Horiguchi et al.	327/544
*	J	US-5,880,604	03-1999	Kawahara et al.	326/83
*	К	US-5,801,576	09-1998	Ooishi, Tsukasa	327/530
*	L	US-5,672,995	09-1997	Hirase et al.	327/534
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р	•				
	a					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.